# **TEST REPORT**

Product: 2ACK3-A4000-E1

Model No.: Action Camera

Trade mark: A4000-E1

Additional Model No.: A4000-C1, A4000-D1

Report No.: TCT171211E023

Issued Date: November 27, 2017

#### Issued for:

Shenzhen Aobaisen Electronic Technology CO., Ltd 4 F, Building A, Chuangyu Industry Area, No.1222 Guanguang Road, Guanlan Street, Longhua New District, Shenzhen, China

#### Issued By:

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## 1. Test Certification

Product:	Action Camera
Model No.:	A4000-E1
Additional Model No.:	A4000-C1, A4000-D1
Applicant:	Shenzhen Aobaisen Electronic Technology CO., Ltd
Address:	4 F, Building A, Chuangyu Industry Area, No.1222 Guanguang Road, Guanlan Street, Longhua New District, Shenzhen, China
Manufacturer:	Shenzhen Aobaisen Electronic Technology CO., Ltd
Address:	4 F, Building A, Chuangyu Industry Area, No.1222 Guanguang Road, Guanlan Street, Longhua New District, Shenzhen, China
Test Voltage:	110V/60Hz
Date of Test:	Nov. 01, 2017 to Nov. 25, 2017
Applicable Standards:	47 CFR FCC Part 15 Subpart B ANSI C63.4: 2014

The above equipment has been tested by Shenzhen Tongce Testing Lab and found compliance with the requirements set forth in the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Tested By:

Date:

Nov. 25, 2017

Hanley

Check By:

Date:

Nov. 27, 2017

Approved By:

Date:

Nov. 27, 2017

## 2. Test Result Summary

Emission				
Test Method	Item	Result		
FCC 47 CFR Part 15 Subpart B	Conducted Emission at Mains Terminals	Pass		
1 00 47 OF ICT OF OUDPAIL D	Radiated Emission	Pass		

#### Note:

- 1. Pass: Test item meets the requirement.
- 2. Fail: Test item does not meet the requirement.
- 3. N/A: Test case does not apply to the test object.
- 4. The test result judgment is decided by the limit of test standard.
- 5. The information of measurement uncertainty is available upon the customer's request.



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## 3. EUT Description

Product Name:	Action Camera
Model No.:	A4000-E1
Additional Model No.:	A4000-C1, A4000-D1
Power supply:	Li-Polymer Battery : S009 Voltage: 3.7V Capacity: 900mAh Limited Charge Voltage: 4.2V

Model(s) List

No.	Model Number	Tested With
1 (	A4000-E1	
Other models	A4000-C1, A4000-D1	

Note: A4000-E1 is tested model, other models are derivative models. The models are identical in circuit and PCB layout, only different on the model names. So the test data of A4000-E1 can represent the remaining models.

## 4. Test Methodology

### 4.1. Decision of Final Test Mode

The EUT was tested together with the thereinafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed:

Pretest Mode	Description		
Mode 1	Video Recording		
Model 2	Video Playing		
Mode 3	Exchange data with computer		

## 4.2. EUT System Operation

- 1. Set up EUT with the support equipments.
- 2. Make sure the EUT work normally during the test.



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## 5. Setup of Equipment under Test

## 5.1. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
1	1	1	1	1

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.	Note
1	PC	ThinkPad	ThinkPad E450	/	/
2	Adapter	ThinkPad	DALX65NCC3A	16	/

#### Note:

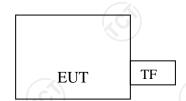
- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



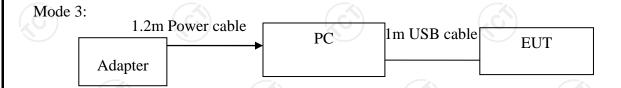
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## 5.2. Configuration of System Under Test

Mode 1&2



(EUT: Action Camera)



(EUT: Action Camera)

I/O Port of EUT				
I/O Port Type Q'TY Cable Tested with				
Power	1	1m USB cable, unshielded	1 (0	

## 6. Facilities and Accreditations

#### 6.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 645098

Shenzhen Tongce Testing Lab

The 3m Semi-anechoic chamber has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

• IC - Registration No.: 10668A-1

The 3m Semi-anechoic chamber of Shenzhen TCT Testing Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing

## 6.2. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

No.	Item	MU
1.	Temperature	±0.1℃
2.	Humidity	±1.0 %
3.	Spurious Emissions, Conducted	±2.56 dB
4.	All Emissions, Radiated	±4.28 dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95 % confidence level using a coverage factor of k=2.



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## 7. Emission Test

## 7.1. Conducted Emission at Mains Terminals

### 7.1.1. Test Specification

Test Requirement:	FCC 47 CFR Part 15 Subpart B
Test Method:	ANSI C63.4: 2014
Frequency Range:	150 kHz to 30 MHz

#### 7.1.2. Limits

Frequency	Class A	dB(uV)	Class	Class B dB(uV)		
(MHz)	Quasi-peak	Average	Quasi-peak	Average		
0.15 - 0.5	79	66	66 – 56 <sup>a</sup>	56 – 46 <sup>a</sup>		
0.50 - 5.0	73	60	56	46		
5.0 - 30.0	73	60	60	50		
a. Decreases with the logarithm of the frequency						

#### 7.1.3. Test Instruments

Conducted Emission Shielding Room Test Site (843)									
Equipment	Manufacturer	Model	Serial Number	Calibration Due					
EMI Test Receiver	R&S	ESCS30	100139	Sep. 27, 2018					
LISN	Schwarzbeck	NSLK 8126	8126453	Sep. 27, 2018					

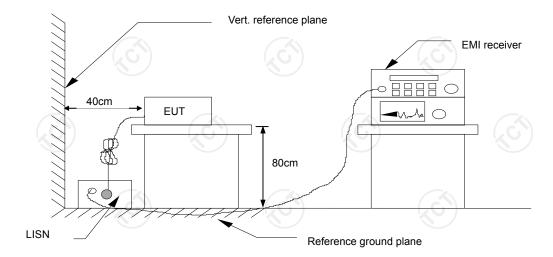
**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

#### 7.1.4. Test Method

The AMN was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane. This distance was between the closest points of the AMN and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the AMN. All power was connected to the system through Artificial Mains Network (AMN). Conducted voltage measurements on mains lines were made at the output of the AMN

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### 7.1.5. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### 7.1.6. Test Results

Test Environment:	Temp.: 23 ℃	Humid.:	51 % Pres	s.: 96hPa
Test Mode:	Mode 3			
Test Voltage:	110V/60Hz			
Test Result:	Pass			

# This is the worst pattern data Note:

L1 = Live Line / N = Neutral Line

Freq. = Emission frequency in MHz

Reading level (dBµV) = Receiver reading

Correct Factor (dB) = LISN factor + Cable loss

Measurement ( $dB\mu V$ ) = Reading level ( $dB\mu V$ ) + Corr. Factor (dB)

Limit (dBµV) = Limit stated in standard

Margin (dB) = Measurement (dB $\mu$ V) – Limits (dB $\mu$ V)

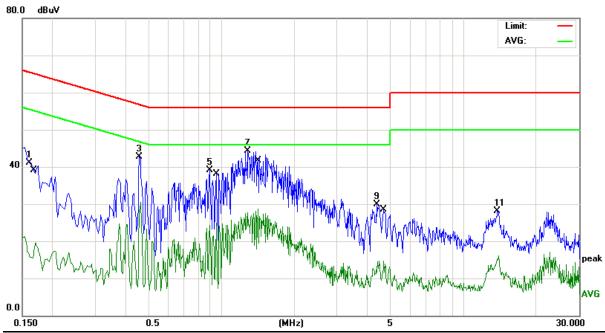
Q.P. =Quasi-Peak AVG =average

\* is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz.

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### Please refer to following diagram for individual

L:



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector
1		0.1607	30.66	10.44	41.10	65.42	-24.32	peak
2		0.1700	9.14	10.44	19.58	54.96	-35.38	AVG
3		0.4580	32.23	10.40	42.63	56.73	-14.10	peak
4		0.4620	20.05	10.40	30.45	46.66	-16.21	AVG
5		0.8900	28.85	10.35	39.20	56.00	-16.80	peak
6		0.9500	14.60	10.35	24.95	46.00	-21.05	AVG
7	*	1.2860	33.92	10.33	44.25	56.00	-11.75	peak
8		1.4140	18.34	10.32	28.66	46.00	-17.34	AVG
9		4.3780	19.74	10.24	29.98	56.00	-26.02	peak
10		4.6940	4.47	10.24	14.71	46.00	-31.29	AVG
11		13.7780	17.89	10.16	28.05	60.00	-31.95	peak
12		13.9340	5.85	10.16	16.01	50.00	-33.99	AVG

Report No.: TCT171211E023 N: 80.0 dBuV Limit: AVG: AVG 0.0 0.150 (MHz) 30.000 Reading Correct Measure-Limit Over Freq. No. Mk. Level Factor ment MHz dBuV dB. dBuV dBuV dΒ Detector 0.1580 34.57 10.44 45.01 65.56 -20.55peak 2 0.1580 10.64 10.44 21.08 55.56 -34.48AVG 3 0.17808.02 10.44 18.46 54.57 -36.11AVG 4 0.194027.50 10.43 37.93 63.86 -25.93peak 5 0.4620 24.76 10.40 35.16 56.66 -21.50peak 6 0.4620 13.58 10.40 23.98 46.66 -22.68AVG 7 1.3500 26.81 10.32 37.13 56.00 -18.87peak 8 1.3860 12.30 10.32 22.62 46.00 -23.38AVG 9 1.6980 22.96 10.31 33.27 56.00 -22.73peak 10 1.7340 8.23 10.30 18.53 46.00 -27.47 AVG 11 23.9980 3.52 10.10 13.62 50.00 -36.38AVG 25.50 12 24.0580 15.40 10.10 60.00 -34.50peak

## 7.2. Radiated Emission

### 7.2.1. Test Specification

Test Requirement:	FCC 47 CFR Part 15 Subpart B	
Test Method:	ANSI C63.4: 2014	
Frequency Range:	30 MHz to 1000 MHz	
Measurement Distance:	3 m	
Antenna Polarization:	Horizontal & Vertical	

#### 7.2.2. Limits

Fraguency (MU=)	Class A (at 3m)	Class B (at 3m)		
Frequency (MHz)	dBuV/m	dBuV/m		
30 ~ 88	49.0	40.0		
88 ~ 216	53.5	43.5		
216 ~ 960	56.4	46.0		
960 ~ 1000	59.5	54.0		

#### Note:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level  $dB(\mu V/m) = 20 \log Emission level (\mu V/m)$ .

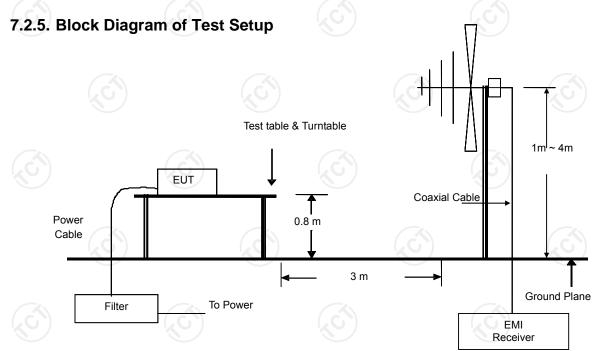
### 7.2.3. Test Instruments

	Radiated Emission Test Site (966)									
Name of Equipment	Manutacturer   Model		Calibration Due							
EMI Test Receiver	R&S	ESVD	100008	Sep. 27, 2018						
Spectrum Analyzer	R&S	FSEM	848597-001	Sep. 27, 2018						
Amplifier	HP	8447D	2727A05017	Sep. 27, 2018						
Amplifier	EM	EM30265	07032613	Sep. 27, 2018						
Broadband Antenna	Schwarzbeck	VULB9163	340	Sep. 27, 2018						
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Sep. 27, 2018						

**Note:** The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

#### 7.2.4. Test Method

Measurements were made in a 3-meter semi-anechoic chamber or Open Area Test Site that complies to CISPR 16. Preliminary (peak) measurements were performed at an antenna to EUT separation distance of 3 meter. The EUT was rotated 360° about its azimuth with the receive antenna located at various heights in horizontal and vertical polarities. Final measurements (quasi-peak) were then performed by rotating the EUT 360° and adjusting the receive antenna height from 1 to 4 m. All frequencies were investigated in both horizontal and vertical antenna polarity, where applicable. Block Diagram of Test Setup.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

#### 7.2.6. Test Results

Test Environment:	Temp.:	23	$^{\circ}$	Humid.:	51 %	Press.:	96hPa
Test Mode:	Mode 3		(c)			-31)	
Test Voltage:	110V/60	Hz					
Test Result:	Pass	7			·		

#### This is the worst pattern data

Freq. = Emission frequency in MHz

Reading level (dBµV) = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss-AMP factor

Measurement ( $dB\mu V$ ) = Reading level ( $dB\mu V$ ) + Corr. Factor (dB)

Limit (dBµV) = Limit stated in standard

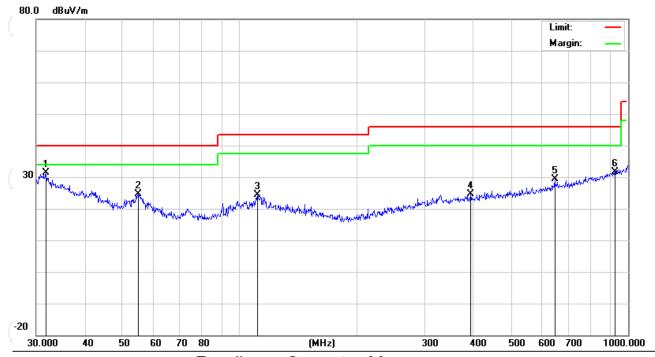
Margin (dB) = Measurement (dB $\mu$ V) – Limits (dB $\mu$ V))

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<sup>\*</sup> is meaning the worst frequency has been tested in the test frequency range

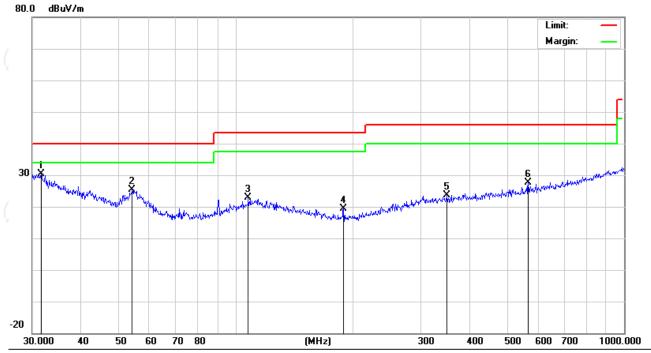
### Please refer to following diagram for individual

#### H:



	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector
	1	*	31.7313	27.21	4.13	31.34	40.00	-8.66	QP
(	2		55.0274	30.16	-5.62	24.54	40.00	-15.46	QP
	3		111.3468	26.30	-2.00	24.30	43.50	-19.20	QP
	4		393.4723	26.28	-1.56	24.72	46.00	-21.28	QP
	5		647.3856	27.79	1.50	29.29	46.00	-16.71	QP
	6		925.7563	25.65	6.00	31.65	46.00	-14.35	QP

### $\mathbf{V}_{:}$



(	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBu∀	dB	dBuV/m	dBuV/m	dB	Detector
	1	*	31.6202	26.24	4.17	30.41	40.00	-9.59	QP
	2		54.2610	31.01	-5.53	25.48	40.00	-14.52	QP
(	3		107.8877	25.17	-2.28	22.89	43.50	-20.61	QP
	4		189.7385	26.67	-7.19	19.48	43.50	-24.02	QP
	5		350.4768	25.31	-1.58	23.73	46.00	-22.27	QP
	6		566.6223	26.56	1.15	27.71	46.00	-18.29	QP



### **TEST RESULTS (1GHz to 25GHz)**

This is the worst pattern data

Temperature	23 °C	Relative Humidity	51%
Pressure	96 hPa	Test Mode	Mode 3

Freq.	Ant.	Emission Level(dBuV		Limit 3m(dBuV/m)		Over(dB)	
(MHz)	Pol.						
	H/V	PK	AV	PK	AV	PK	AV
4809.12	V	60.30	40.84	74	54	-13.70	-13.16
7207.08	V	58.94	39.60	74	54	-15.06	-14.40
4802.93	Н	59.71	39.41	74	54	-14.29	-14.59
7207.95	H	59.75	40.75	74	54	-14.25	-13.25

#### Remark:

All emissions not reported were more than 20dB below the specified limit or in the noise floor. Factor = Antenna Factor + Cable Loss - Pre-amplifier.

All the x/y/z orientation has been investigated, and only worst case is presented in this report.



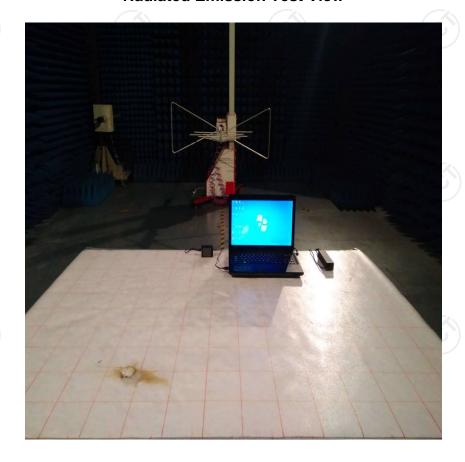
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# 8. Photographs of Test Configuration

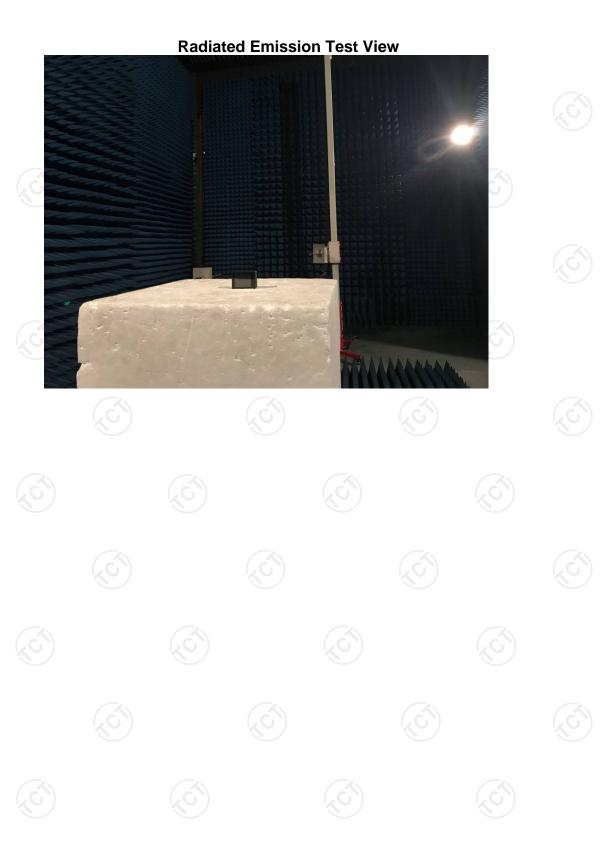
**Conducted Emission Test View** 



**Radiated Emission Test View** 



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Report No.: TCT171211E023 **Photographs of EUT** 9. Refer to test report TCT171211E022 \*\*\*\*\*END OF REPORT\*\*\*\*

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